

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $R_{DS(on)}$ and to ensure minimal power loss and heat dissipation.

FEATURES

- Low $R_{DS(on)}$ trench technology
- Low thermal impedance
- Fast switching speed

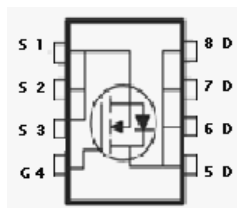
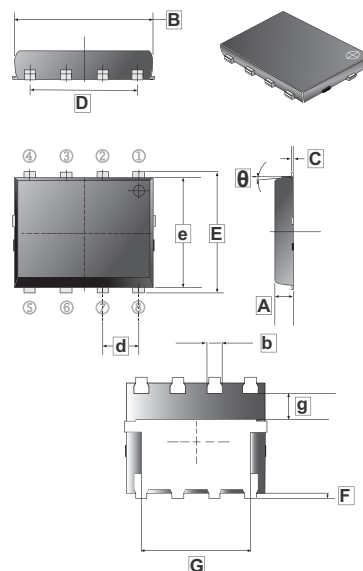
APPLICATION

- Industrial D/C/DC conversion circuits
- White LED boost converters
- Automotive systems

PACKAGE INFORMATION

Package	MPQ	Leader Size
DFN3x3-8PP	3K	13 inch

DFN3x3-8PP



REF.	Millimeter	REF.	Millimeter
Min.	Max.	Min.	Max.
A	0.70	0.90	θ
B	3.00BSC	b	0.20
C	0.10	0.25	d
D	1.80	2.3	e
E	3.2BSC	g	0.70(TYP)
F	0.01	0.02	
G	2.35BSC		

MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹	I_D	$T_A=25^\circ\text{C}$	19
		$T_A=70^\circ\text{C}$	16
Pulsed Drain Current ²	I_{DM}	80	A
Continuous Source Current (Diode Conduction) ¹	I_S	5.1	A
Power Dissipation ¹	P_D	$T_A=25^\circ\text{C}$	3.5
		$T_A=70^\circ\text{C}$	2
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~150	$^\circ\text{C}$
Thermal Resistance Ratings			
Maximum Thermal Resistance from Junction to Ambient ¹	$t \leq 10 \text{ sec}$	$R_{\theta JA}$	35
	Steady State		81

Notes:

1. The surface of the device is mounted on a 1" x 1" FR4 board.
2. The pulse width is limited by the maximum junction temperature.

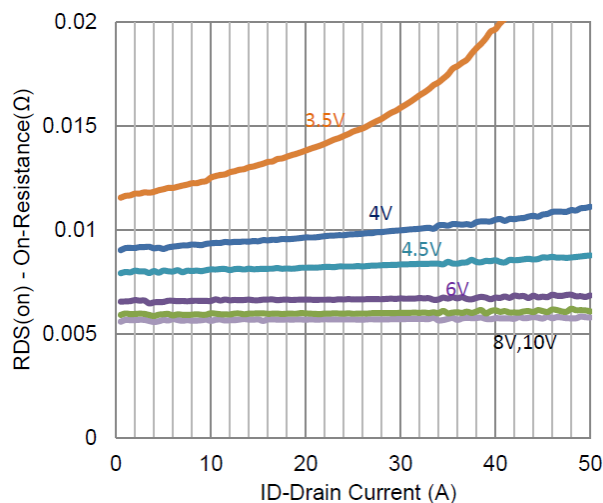
ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Static ¹						
Gate-Source Threshold Voltage	$V_{GS(th)}$	1	-	-	V	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$
Gate-Body Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{DS}=0\text{V}$, $V_{GS}=\pm 20\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1	μA	$V_{DS}=24\text{V}$, $V_{GS}=0$
		-	-	25		$V_{DS}=24\text{V}$, $V_{GS}=0$, $T_J=55^\circ\text{C}$
On-State Drain Current	$I_{D(on)}$	40	-	-	A	$V_{DS}=5\text{V}$, $V_{GS}=10\text{V}$
Drain-Source On-Resistance	$R_{DS(ON)}$	-	-	6.9	m Ω	$V_{GS}=10\text{V}$, $I_D=17.6\text{A}$
		-	-	9.8		$V_{GS}=4.5\text{V}$, $I_D=12.4\text{A}$
Forward Transconductance	g_{fs}	-	30	-	S	$V_{DS}=15\text{V}$, $I_D=17.6\text{A}$
Diode Forward Voltage	V_{SD}	-	0.72	-	V	$I_S=2.6\text{A}$, $V_{GS}=0$
Dynamic ¹						
Total Gate Charge	Q_g	-	20	-	nC	$V_{DS}=15\text{V}$ $V_{GS}=4.5\text{V}$ $I_D=17.6\text{A}$
Gate-Source Charge	Q_{gs}	-	7.1	-		
Gate-Drain Charge	Q_{gd}	-	9.2	-		
Input Capacitance	C_{iss}	-	1835	-	pF	$V_{DS}=15\text{V}$ $V_{GS}=0$ $f=1\text{MHz}$
Output Capacitance	C_{oss}	-	315	-		
Reverse Transfer Capacitance	C_{rss}	-	303	-		
Turn-On Delay Time	$T_{d(on)}$	-	4	-	nS	$V_{DS}=15\text{V}$ $V_{GEN}=10\text{V}$ $I_D=17.6\text{A}$ $R_L=0.9\Omega$ $R_{GEN}=6\Omega$
Rise Time	T_r	-	66	-		
Turn-Off Delay Time	$T_{d(off)}$	-	53	-		
Fall Time	T_f	-	30	-		

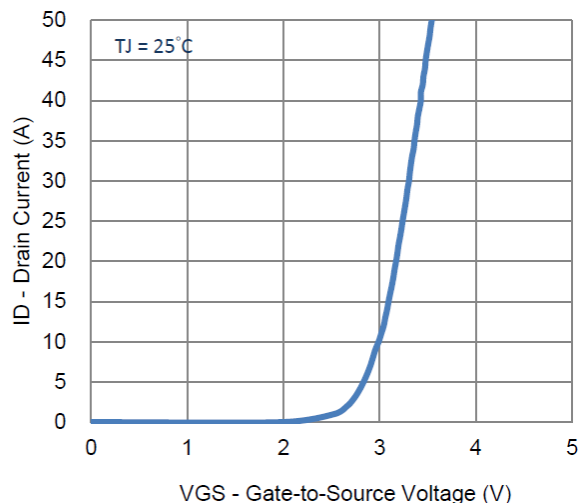
Notes:

1. Pulse test : $PW \leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

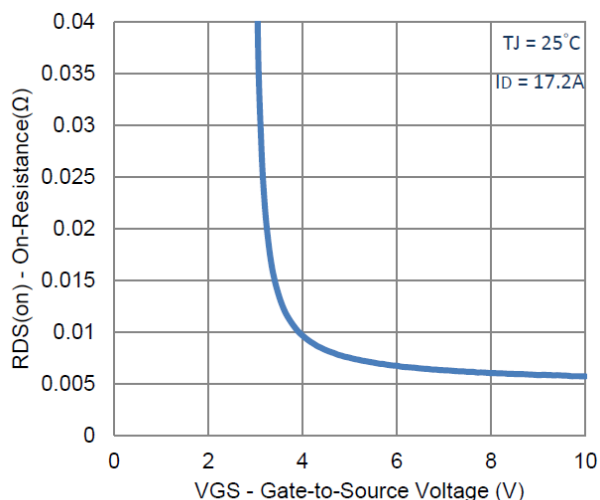
CHARACTERISTIC CURVE



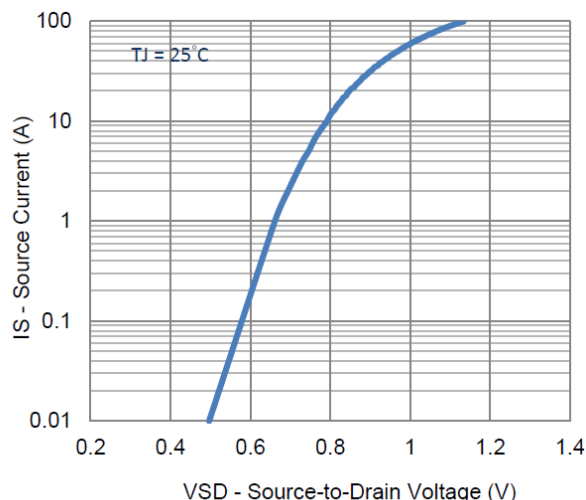
1. On-Resistance vs. Drain Current



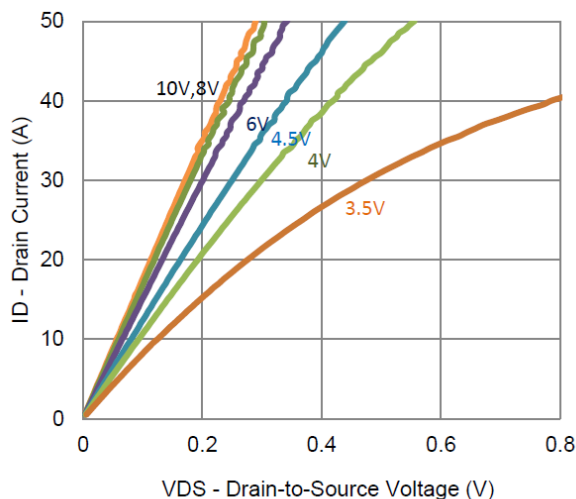
2. Transfer Characteristics



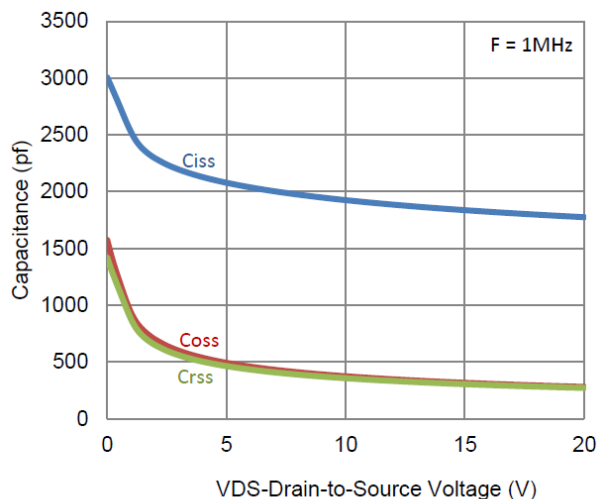
3. On-Resistance vs. Gate-to-Source Voltage



4. Drain-to-Source Forward Voltage

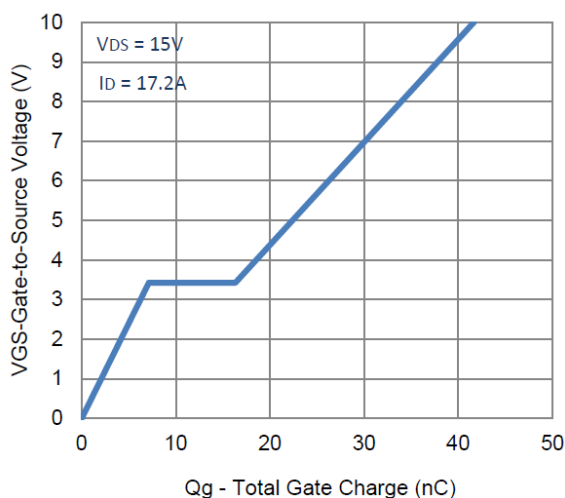


5. Output Characteristics

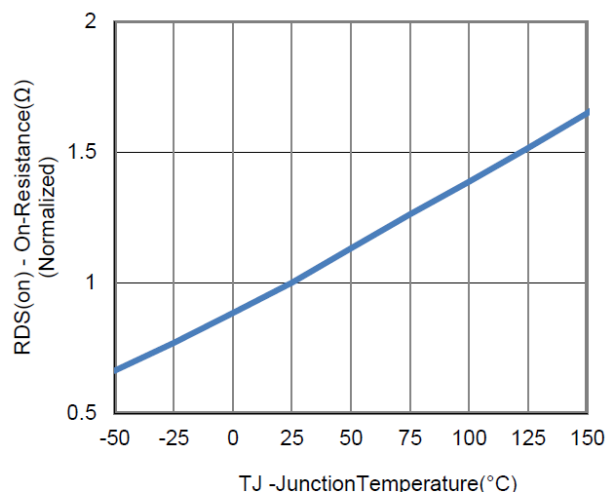


6. Capacitance

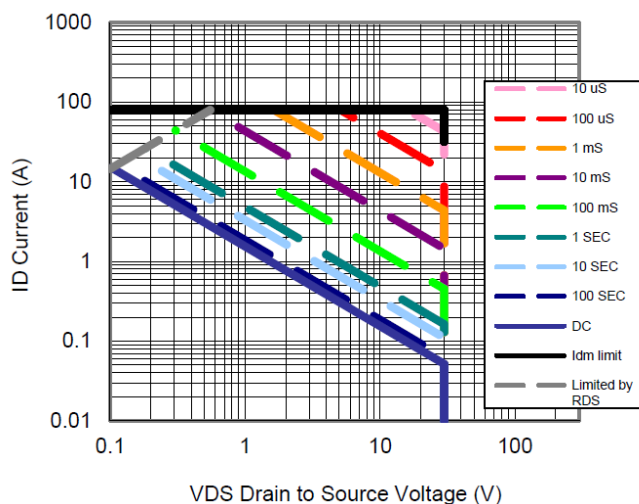
CHARACTERISTIC CURVE



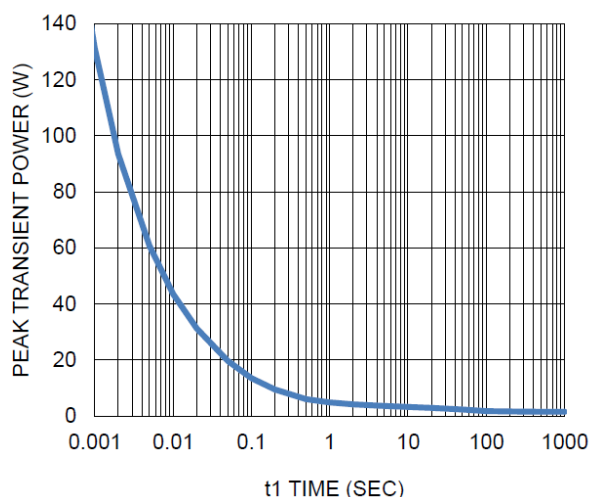
7. Gate Charge



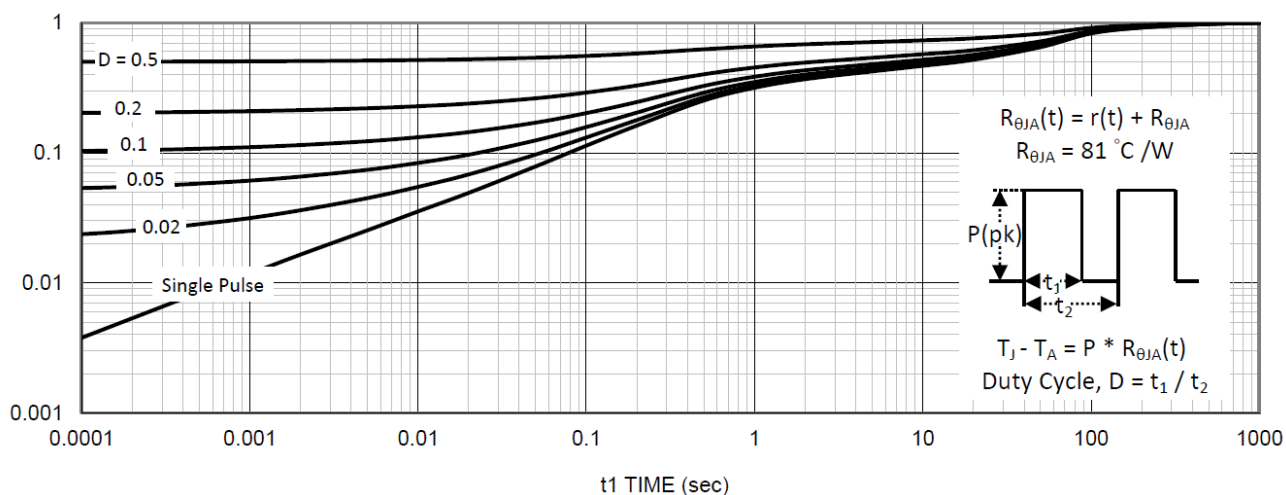
8. Normalized On-Resistance Vs Junction Temperature



9. Safe Operating Area



10. Single Pulse Maximum Power Dissipation



11. Normalized Thermal Transient Junction to Ambient